

# Search Notes



Application/Control No.

10/668,643

Examiner

Mark K. Han

Applicant(s)/Patent under Reexamination

TROCKI ET AL.

Art Unit

3767

## SEARCHED

Class	Subclass	Date	Examiner
604	93.01	3/20/2006	mbh.
	118		
	154		
	131		
	152		
	181		
	187		
	533		
	534		
	535		
600	431		
	432		
128	dig.1		
	dig.12		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST text search	3/20/2006	mbh.
Inventor name search	3/20/2006	mbh.